Application/Control No. Applicant(s)/Patent Under Reexamination 10/541,873 YOSHIMITSU ET AL. **Notice of References Cited** Art Unit Examiner Page 1 of 1 Cheung Lee 2812 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-2006/0179627	08-2006	Sakai et al.	029/025.03
Х	В	US-2006/0223976	10-2006	Tozawa et al.	528/373
	. С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			-
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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